## PSMN3R0-60BS



# N-channel 60 V 3.2 mΩ standard level MOSFET in D2PAK Rev. 1 — 22 March 2012 Product data

**Product data sheet** 

## **Product profile**

#### 1.1 General description

Standard level N-channel MOSFET in a D2PAK package qualified to 175 °C. This product is designed and qualified for use in a wide range of industrial, communications and domestic equipment.

#### 1.2 Features and benefits

- High efficiency due to low switching and conduction losses
- Suitable for standard level gate drive sources

#### 1.3 Applications

- DC-to-DC converters
- Load switching

- Motor control
- Server power supplies

#### 1.4 Quick reference data

Table 1. Quick reference data

Parameter	Conditions		Min	Тур	Max	Unit
drain-source voltage	T <sub>j</sub> ≥ 25 °C; T <sub>j</sub> ≤ 175 °C		-	-	60	V
drain current	$T_{mb}$ = 25 °C; $V_{GS}$ = 10 V; see Figure 1	[1]	-	-	100	Α
total power dissipation	T <sub>mb</sub> = 25 °C; see <u>Figure 2</u>		-	-	306	W
junction temperature			-55	-	175	°C
acteristics						
drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 25 \text{ A}; T_j = 100 °C;$ see <u>Figure 12</u> ; see <u>Figure 13</u>		-	4.32	5.1	mΩ
	$V_{GS} = 10 \text{ V; } I_D = 25 \text{ A; } T_j = 25 \text{ °C;}$ see Figure 13		-	2.7	3.2	mΩ
naracteristics						
gate-drain charge	$V_{GS} = 10 \text{ V}; I_D = 25 \text{ A}; V_{DS} = 30 \text{ V};$		-	28	-	nC
total gate charge	see Figure 14; see Figure 15		-	130	-	nC
ruggedness						
non-repetitive drain-source avalanche energy	$V_{GS}$ = 10 V; $T_{j(init)}$ = 25 °C; $I_D$ = 100 A; $V_{sup}$ ≤ 60 V; $R_{GS}$ = 50 $\Omega$ ; unclamped		-	-	800	mJ
	drain-source voltage drain current  total power dissipation junction temperature acteristics drain-source on-state resistance  paracteristics gate-drain charge total gate charge ruggedness non-repetitive drain-source	drain-source voltage $T_j \ge 25  ^{\circ}\text{C};  T_j \le 175  ^{\circ}\text{C}$ drain current $T_{mb} = 25  ^{\circ}\text{C};  V_{GS} = 10  \text{V};$ $see  \underline{Figure}  1$ total power dissipation $T_{mb} = 25  ^{\circ}\text{C};  see  \underline{Figure}  2$ junction temperature  deteristics  drain-source on-state resistance $V_{GS} = 10  \text{V};  I_D = 25  \text{A};  T_j = 100  ^{\circ}\text{C};$ $see  \underline{Figure}  12;  see  \underline{Figure}  13$ $V_{GS} = 10  \text{V};  I_D = 25  \text{A};  T_j = 25  ^{\circ}\text{C};$ $see  \underline{Figure}  13$ varacteristics  gate-drain charge $V_{GS} = 10  \text{V};  I_D = 25  \text{A};  V_{DS} = 30  \text{V};$ total gate charge $V_{GS} = 10  \text{V};  I_D = 25  \text{A};  V_{DS} = 30  \text{V};$ total gate charge $V_{GS} = 10  \text{V};  I_D = 25  \text{A};  V_{DS} = 30  \text{V};$ $v_{GS} = 10  \text{V};  v_{DS} = 25  \text{C};$ $v_{CS} = 10  \text{V};  v_{CS} = 10  \text{V};  v_{CS} = 10  \text{V};$ $v_{CS} = 10  $	drain-source voltage $T_j \ge 25 ^{\circ}\text{C};  T_j \le 175 ^{\circ}\text{C}$ drain current $T_{mb} = 25 ^{\circ}\text{C};  V_{GS} = 10 \text{V};  \text{II}$ total power dissipation $T_{mb} = 25 ^{\circ}\text{C};  \text{see Figure 2}$ junction temperature  deteristics  drain-source on-state resistance $V_{GS} = 10 \text{V};  I_D = 25 \text{A};  T_j = 100 ^{\circ}\text{C};  \text{see Figure 12};  \text{see Figure 13}$ $V_{GS} = 10 \text{V};  I_D = 25 \text{A};  T_j = 25 ^{\circ}\text{C};  \text{see Figure 13}$ varacteristics  gate-drain charge $V_{GS} = 10 \text{V};  I_D = 25 \text{A};  V_{DS} = 30 \text{V};  \text{see Figure 14};  \text{see Figure 15}$ ruggedness  non-repetitive drain-source avalanche energy $V_{GS} = 10 \text{V};  T_{j(init)} = 25 ^{\circ}\text{C};  I_D = 100 \text{A};  V_{sup} \le 60 \text{V};  R_{GS} = 50 \Omega;$	drain-source voltage $T_j \ge 25 ^{\circ}\text{C};  T_j \le 175 ^{\circ}\text{C}$ - drain current $T_{mb} = 25 ^{\circ}\text{C};  V_{GS} = 10  \text{V};$ [1] - see Figure 1 total power dissipation $T_{mb} = 25 ^{\circ}\text{C};  \text{see Figure 2}$ - junction temperature -55 drain-source on-state resistance $V_{GS} = 10  \text{V};  I_D = 25  \text{A};  T_j = 100 ^{\circ}\text{C};$ - see Figure 12; see Figure 13 $V_{GS} = 10  \text{V};  I_D = 25  \text{A};  T_j = 25 ^{\circ}\text{C};$ - see Figure 13 $V_{GS} = 10  \text{V};  I_D = 25  \text{A};  T_j = 25 ^{\circ}\text{C};$ - see Figure 13 $V_{GS} = 10  \text{V};  I_D = 25  \text{A};  V_{DS} = 30  \text{V};$ total gate charge $V_{GS} = 10  \text{V};  I_D = 25  \text{A};  V_{DS} = 30  \text{V};$ see Figure 14; see Figure 15 - $V_{GS} = 10  \text{V};  V_{SS} = 30  \text{V};$ - see Figure 15 - $V_{SS} = 10  \text{V};  V_{SS} = 10  \text{V};  V_{S$	drain-source voltage $T_j \ge 25 ^{\circ}\text{C};  T_j \le 175 ^{\circ}\text{C}$ drain current $T_{mb} = 25 ^{\circ}\text{C};  V_{GS} = 10 \text{V};$ see Figure 1 see Figure 2 junction temperature -55 - deteristics drain-source on-state resistance $V_{GS} = 10 \text{V};  I_D = 25 \text{A};  T_j = 100 ^{\circ}\text{C};$ - 4.32 see Figure 12; see Figure 13 $V_{GS} = 10 \text{V};  I_D = 25 \text{A};  T_j = 25 ^{\circ}\text{C};$ - 2.7 see Figure 13 $V_{GS} = 10 \text{V};  I_D = 25 \text{A};  V_{DS} = 30 \text{V};$ see Figure 14; see Figure 15 - 130 ruggedness non-repetitive drain-source avalanche energy $V_{GS} = 10 \text{V};  T_{j(init)} = 25 ^{\circ}\text{C};$	drain-source voltage $T_j \ge 25  ^{\circ}\text{C};  T_j \le 175  ^{\circ}\text{C}$ 60 drain current $T_{mb} = 25  ^{\circ}\text{C};  V_{GS} = 10  \text{V};$ $11  -  -  100  \text{C}$ see Figure 1 - 306 junction temperature $T_{mb} = 25  ^{\circ}\text{C};  \text{see Figure 2}$ 306 junction temperature $T_{mb} = 25  ^{\circ}\text{C};  \text{see Figure 2}$ 175 interestics $ \frac{\text{drain-source on-state}}{\text{drain-source on-state}}  \frac{V_{GS} = 10  \text{V};  I_D = 25  \text{A};  T_j = 100  ^{\circ}\text{C};  -  2.7  3.2  \text{See Figure 13}  \text{V}_{GS} = 10  \text{V};  I_D = 25  \text{A};  T_j = 25  ^{\circ}\text{C};  -  2.7  3.2  \text{See Figure 13}  \text{V}_{GS} = 10  \text{V};  I_D = 25  \text{A};  V_{DS} = 30  \text{V};  -  28  -  \text{See Figure 14};  \text{see Figure 15}  \text{See Figure 15}  \text{See Figure 16}  See Figure 16$

<sup>[1]</sup> Continuous current is limited by package



## 2. Pinning information

Table 2. Pinning information

I GOIO E.		, information		
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		
2	D	drain <sup>[1]</sup>	mb	D
3	S	source		
mb	D	mounting base; connected to drain		mbb076 S
			SOT404 (D2PAK)	

<sup>[1]</sup> It is not possible to make connection to pin 2

## 3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
PSMN3R0-60BS	D2PAK	plastic single-ended surface-mounted package (D2PAK); 3 leads (one lead cropped)	SOT404

## 4. Marking

Table 4. Marking codes

Type number	Marking code
PSMN3R0-60BS	PSMN3R0-60BS

## 5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

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Symbol	Parameter	Conditions		Min	Max	Unit
$V_{DS}$	drain-source voltage	T <sub>j</sub> ≥ 25 °C; T <sub>j</sub> ≤ 175 °C		-	60	V
$V_{DGR}$	drain-gate voltage	$T_j \ge 25$ °C; $T_j \le 175$ °C; $R_{GS} = 20$ kΩ		-	60	V
$V_{GS}$	gate-source voltage			-20	20	V
$I_D$	drain current	$V_{GS} = 10 \text{ V}; T_{mb} = 100 \text{ °C}; \text{ see } \frac{\text{Figure 1}}{}$	<u>[1]</u>	-	83.4	Α
		$V_{GS} = 10 \text{ V}; T_{mb} = 25 \text{ °C}; \text{ see } \frac{\text{Figure 1}}{\text{Model}}$	<u>[1]</u>	-	100	Α
I <sub>DM</sub>	peak drain current	pulsed; $t_p \le 10 \mu s$ ; $T_{mb} = 25 \degree C$ ; see Figure 3		-	824	Α
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> = 25 °C; see <u>Figure 2</u>		-	306	W
T <sub>stg</sub>	storage temperature			-55	175	°C
Tj	junction temperature			-55	175	°C
T <sub>sld(M)</sub>	peak soldering temperature			-	260	°C
Source-dra	ain diode					
Is	source current	T <sub>mb</sub> = 25 °C	<u>[1]</u>	-	100	Α
I <sub>SM</sub>	peak source current	pulsed; $t_p \le 10 \ \mu s$ ; $T_{mb} = 25 \ ^{\circ}C$		-	824	Α
Avalanche	ruggedness					
E <sub>DS(AL)S</sub>	non-repetitive drain-source avalanche energy	$V_{GS}$ = 10 V; $T_{j(init)}$ = 25 °C; $I_D$ = 100 A; $V_{sup}$ ≤ 60 V; $R_{GS}$ = 50 Ω; unclamped		-	800	mJ

#### [1] Continuous current is limited by package

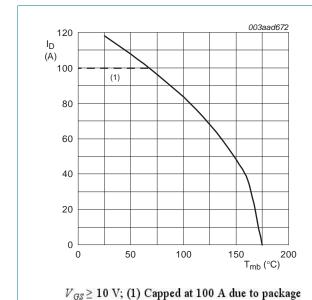


Fig 1. Continuous drain current as a function of mounting base temperature.

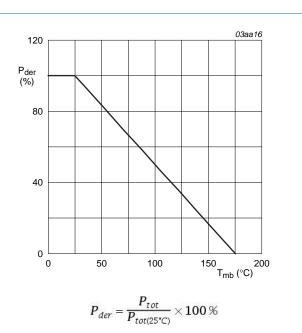


Fig 2. Normalized total power dissipation as a function of mounting base temperature

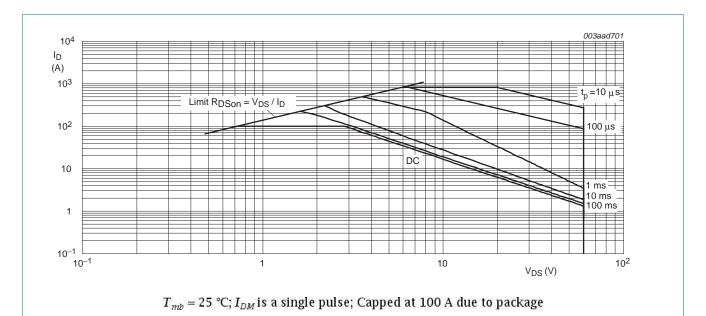


Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

## 6. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-mb)}$	thermal resistance from junction to mounting base	see Figure 4	-	0.3	0.49	K/W
$R_{th(j-a)}$	thermal resistance from junction to ambient	Minimum footprint; mounted in a printed circuit board	-	50	-	K/W

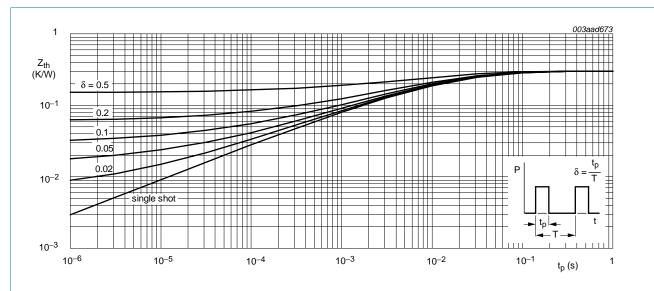


Fig 4. Transient thermal impedance from junction to mounting base as a function of pulse duration

## 7. Characteristics

Table 7. Characteristics

	Typ  3 - 0.05 - 10 10 4.32 6.21	Max 4 - 4.6 10 500 100 5.1 7.3	V V V V µA µA nA nA
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	- 0.05 - 10 10 4.32 6.21	- 4 - 4.6 10 500 100 100 5.1	V V V V μΑ μΑ nA
$V_{GS(th)} \qquad \text{voltage} \qquad I_D = 250 \ \mu\text{A; } V_{GS} = 0 \ V; \ T_j = 25 \ ^{\circ}\text{C} \qquad 60$ $V_{GS(th)} \qquad \text{gate-source threshold voltage} \qquad I_D = 1 \ \text{mA; } V_{DS} = V_{GS;} \ T_j = 25 \ ^{\circ}\text{C}; \qquad 2 \\ \text{see Figure 10; see Figure 11} \qquad 2 \\ \text{V}_{GSth} \qquad \text{gate-source threshold voltage} \qquad I_D = 1 \ \text{mA; } V_{DS} = V_{GS;} \ T_j = 175 \ ^{\circ}\text{C}; \qquad 1 \\ \text{see Figure 11} \qquad I_D = 1 \ \text{mA; } V_{DS} = V_{GS;} \ T_j = 175 \ ^{\circ}\text{C}; \qquad 1 \\ \text{see Figure 11} \qquad I_D = 1 \ \text{mA; } V_{DS} = V_{GS;} \ T_j = 175 \ ^{\circ}\text{C}; \qquad 1 \\ \text{see Figure 11} \qquad I_D = 1 \ \text{mA; } V_{DS} = 0 \ \text{V; } V_j = 25 \ ^{\circ}\text{C}; \qquad 1 \\ \text{see Figure 11} \qquad V_{DS} = 60 \ \text{V; } V_{GS} = 0 \ \text{V; } V_j = 25 \ ^{\circ}\text{C}; \qquad 1 \\ \text{V}_{DS} = 60 \ \text{V; } V_{DS} = 0 \ \text{V; } V_j = 25 \ ^{\circ}\text{C}; \qquad 1 \\ \text{V}_{GS} = 20 \ \text{V; } V_{DS} = 0 \ \text{V; } V_j = 25 \ ^{\circ}\text{C}; \qquad 1 \\ \text{V}_{GS} = 20 \ \text{V; } V_{DS} = 0 \ \text{V; } V_j = 25 \ ^{\circ}\text{C}; \qquad 1 \\ \text{V}_{GS} = 20 \ \text{V; } V_{DS} = 0 \ \text{V; } V_j = 25 \ ^{\circ}\text{C}; \qquad 1 \\ \text{V}_{GS} = 20 \ \text{V; } V_{DS} = 0 \ \text{V; } V_j = 25 \ ^{\circ}\text{C}; \qquad 1 \\ \text{V}_{GS} = 10 \ \text{V; } I_j = 25 \ ^{\circ}\text{C}; \qquad 1 \\ \text{See Figure 12; see Figure 13}; \qquad V_{GS} = 10 \ \text{V; } I_j = 25 \ ^{\circ}\text{C}; \qquad 1 \\ \text{See Figure 13}; \qquad V_{GS} = 10 \ \text{V; } I_j = 25 \ ^{\circ}\text{C}; \qquad 1 \\ \text{See Figure 13}; \qquad V_{GS} = 10 \ \text{V; } I_j = 25 \ ^{\circ}\text{C}; \qquad 1 \\ \text{See Figure 13}; \qquad V_{GS} = 10 \ \text{V; } I_j = 25 \ ^{\circ}\text{C}; \qquad 1 \\ \text{See Figure 13}; \qquad V_{GS} = 10 \ \text{V; } I_j = 25 \ ^{\circ}\text{C}; \qquad 1 \\ \text{See Figure 14}; \qquad See Figure 15 \qquad 1 \\ \text{See Figure 15}; \qquad I_j = 25 \ ^{\circ}\text{C}; \qquad 1 \\ \text{See Figure 16}; \qquad I_j = 25 \ ^{\circ}\text{C}; \qquad 1 \\ \text{See Figure 17}; \qquad I_j = 25 \ ^{\circ}\text{C}; \qquad 1 \\ \text{See Figure 19}; \qquad I_j = 25 \ ^{\circ}\text{C}; \qquad 1 \\ \text{See Figure 19}; \qquad I_j = 25 \ ^{\circ}\text{C}; \qquad 1 \\ \text{See Figure 19}; \qquad I_j = 25 \ ^{\circ}\text{C}; \qquad 1 \\ \text{See Figure 19}; \qquad I_j = 25 \ ^{\circ}\text{C}; \qquad 1 \\ \text{See Figure 19}; \qquad I_j = 25 \ ^{\circ}\text{C}; \qquad 1 \\ \text{See Figure 19}; \qquad I_j = 25 \ ^{\circ}\text{C}; \qquad 1 \\ \text{See Figure 19}; \qquad I_j = 25 \ ^{\circ}\text{C}; \qquad 1 \\ \text{See Figure 19}; \qquad I_j = 25 \ ^{\circ}\text{C}; \qquad 1 \\ \text{See Figure 19}; \qquad I_j = 25 \ ^$	- 0.05 - 10 10 4.32 6.21	- 4 - 4.6 10 500 100 100 5.1	V V V V μΑ μΑ nA
$V_{GS(th)}  \text{gate-source threshold voltage}  \begin{array}{l} I_D = 1 \text{ mA; } V_{DS} = V_{GS}, T_j = 25  ^{\circ}\text{C}; \\ \text{see Figure 10; see Figure 11} \\ \hline V_{GSth}  \text{gate-source threshold voltage} \\ V_{DS} = 1 \text{ mA; } V_{DS} = V_{GS}; T_j = 175  ^{\circ}\text{C}; \\ \text{see Figure 11} \\ \hline I_D = 1 \text{ mA; } V_{DS} = V_{GS}; T_j = -55  ^{\circ}\text{C}; \\ \text{see Figure 11} \\ \hline I_{DS}  \text{drain leakage current} \\ \hline V_{DS} = 60  \text{V; } V_{GS} = 0  \text{V; } T_j = 25  ^{\circ}\text{C} \\ \hline V_{DS} = 60  \text{V; } V_{GS} = 0  \text{V; } T_j = 175  ^{\circ}\text{C} \\ \hline V_{DS} = 60  \text{V; } V_{DS} = 0  \text{V; } T_j = 175  ^{\circ}\text{C} \\ \hline V_{CS} = 20  \text{V; } V_{DS} = 0  \text{V; } T_j = 25  ^{\circ}\text{C} \\ \hline V_{CS} = 20  \text{V; } V_{DS} = 0  \text{V; } T_j = 25  ^{\circ}\text{C} \\ \hline V_{CS} = 20  \text{V; } V_{DS} = 0  \text{V; } T_j = 25  ^{\circ}\text{C} \\ \hline V_{CS} = 20  \text{V; } V_{DS} = 0  \text{V; } T_j = 25  ^{\circ}\text{C} \\ \hline V_{CS} = 20  \text{V; } V_{DS} = 0  \text{V; } T_j = 25  ^{\circ}\text{C} \\ \hline V_{CS} = 20  \text{V; } V_{DS} = 0  \text{V; } T_j = 25  ^{\circ}\text{C} \\ \hline V_{CS} = 10  \text{V; } I_D = 25  \text{A; } T_j = 100  ^{\circ}\text{C; } \\ \hline V_{CS} = 10  \text{V; } I_D = 25  \text{A; } T_j = 100  ^{\circ}\text{C; } \\ \hline V_{CS} = 10  \text{V; } I_D = 25  \text{A; } T_j = 175  ^{\circ}\text{C; } \\ \hline V_{CS} = 10  \text{V; } I_D = 25  \text{A; } T_j = 175  ^{\circ}\text{C; } \\ \hline V_{CS} = 10  \text{V; } I_D = 25  \text{A; } T_j = 25  ^{\circ}\text{C; } \\ \hline V_{CS} = 10  \text{V; } I_D = 25  \text{A; } T_j = 25  ^{\circ}\text{C; } \\ \hline V_{CS} = 10  \text{V; } I_D = 25  \text{A; } T_j = 25  ^{\circ}\text{C; } \\ \hline V_{CS} = 10  \text{V; } I_D = 25  \text{A; } T_j = 25  ^{\circ}\text{C; } \\ \hline V_{CS} = 10  \text{V; } I_D = 25  \text{A; } T_j = 25  ^{\circ}\text{C; } \\ \hline V_{CS} = 10  \text{V; } I_D = 25  \text{A; } T_j = 25  ^{\circ}\text{C; } \\ \hline V_{CS} = 10  \text{V; } I_D = 25  \text{A; } T_j = 25  ^{\circ}\text{C; } \\ \hline V_{CS} = 10  \text{V; } I_D = 25  \text{A; } T_j = 25  ^{\circ}\text{C; } \\ \hline V_{CS} = 10  \text{V; } I_D = 25  \text{A; } I_D = 25 $	- 0.05 - 10 10 4.32 6.21	- 4.6 10 500 100 100 5.1	V V V  µA µA nA
$\begin{tabular}{ l l l l l l l l l l l l l l l l l l l$	- 0.05 - 10 10 4.32 6.21	- 4.6 10 500 100 100 5.1	V V μΑ μΑ nA
	- 0.05 - 10 10 4.32 6.21	4.6 10 500 100 100 5.1	V μΑ μΑ nA
$I_{DSS} \qquad \text{drain leakage current} \qquad \frac{\text{see Figure 11}}{\text{V}_{DS} = 60 \text{ V; V}_{GS} = 0 \text{ V; T}_j = 25  ^{\circ}\text{C}} \qquad - \\ V_{DS} = 60 \text{ V; V}_{GS} = 0 \text{ V; T}_j = 175  ^{\circ}\text{C}} \qquad - \\ V_{DS} = 60 \text{ V; V}_{DS} = 0 \text{ V; T}_j = 175  ^{\circ}\text{C}} \qquad - \\ V_{GS} = 20 \text{ V; V}_{DS} = 0 \text{ V; T}_j = 25  ^{\circ}\text{C}} \qquad - \\ V_{GS} = 20 \text{ V; V}_{DS} = 0 \text{ V; T}_j = 25  ^{\circ}\text{C}} \qquad - \\ V_{GS} = 20 \text{ V; V}_{DS} = 0 \text{ V; T}_j = 25  ^{\circ}\text{C}} \qquad - \\ V_{GS} = 20 \text{ V; V}_{DS} = 0 \text{ V; T}_j = 25  ^{\circ}\text{C}} \qquad - \\ V_{GS} = 10 \text{ V; I}_D = 25 \text{ A; T}_j = 100  ^{\circ}\text{C; see Figure 13}} \\ V_{GS} = 10 \text{ V; I}_D = 25 \text{ A; T}_j = 175  ^{\circ}\text{C; see Figure 13}} \\ V_{GS} = 10 \text{ V; I}_D = 25 \text{ A; T}_j = 25  ^{\circ}\text{C; see Figure 13}} \\ V_{GS} = 10 \text{ V; I}_D = 25 \text{ A; T}_j = 25  ^{\circ}\text{C; see Figure 13}} \\ V_{GS} = 10 \text{ V; I}_D = 25 \text{ A; T}_j = 25  ^{\circ}\text{C; see Figure 13}} \\ V_{DS} = 10 \text{ V; I}_D = 25 \text{ A; T}_j = 25  ^{\circ}\text{C; see Figure 13}} \\ V_{DS} = 10 \text{ V; I}_D = 25 \text{ A; T}_j = 25  ^{\circ}\text{C; see Figure 14}} \\ V_{DS} = 10 \text{ V; I}_D = 25 \text{ A; T}_j = 25  ^{\circ}\text{C; see Figure 14}} \\ V_{DS} = 10 \text{ V; I}_D = 25 \text{ A; T}_j = 25  ^{\circ}\text{C; see Figure 14}} \\ V_{DS} = 10 \text{ V; I}_D = 25 \text{ A; T}_j = 25  ^{\circ}\text{C; see Figure 14}} \\ V_{DS} = 10 \text{ V; I}_D = 25 \text{ A; T}_j = 25  ^{\circ}\text{C; see Figure 14}} \\ V_{DS} = 10 \text{ V; I}_D = 25 \text{ A; T}_j = 25  ^{\circ}\text{C; see Figure 14}} \\ V_{DS} = 10 \text{ V; I}_D = 25 \text{ A; T}_j = 25  ^{\circ}\text{C; see Figure 14}} \\ V_{DS} = 10 \text{ V; I}_D = 25 \text{ A; T}_j = 25  ^{\circ}\text{C; see Figure 14}} \\ V_{DS} = 10 \text{ V; I}_D = 25 \text{ A; T}_j = 25  ^{\circ}\text{C; see Figure 14}} \\ V_{DS} = 10 \text{ V; I}_D = 25 \text{ A; T}_j = 25  ^{\circ}\text{C; see Figure 14}} \\ V_{DS} = 10 \text{ V; I}_D = 25 \text{ A; T}_j = 25  ^{\circ}\text{C; see Figure 14}} \\ V_{DS} = 10 \text{ V; I}_D = 25 \text{ A; T}_j = 25  ^{\circ}\text{C; see Figure 14}} \\ V_{DS} = 10 \text{ V; I}_D = 25 \text{ A; T}_j = 25  ^{\circ}\text{C; see Figure 14}} \\ V_{DS} = 10 \text{ V; I}_D = 25 \text{ A; T}_j = 25  ^{\circ}\text{C; see Figure 14}} \\ V_{DS} = 10 \text{ V; I}_D = 25 \text{ A; T}_j = 25  ^{\circ}\text{C; see Figure 14}} \\$	- 10 10 4.32 6.21	10 500 100 100 5.1	μΑ μΑ nA nA
$V_{DS} = 60 \text{ V; } V_{GS} = 0 \text{ V; } T_j = 175 \text{ °C} \qquad - \\ V_{GS} = 20 \text{ V; } V_{DS} = 0 \text{ V; } T_j = 25 \text{ °C} \qquad - \\ V_{GS} = 20 \text{ V; } V_{DS} = 0 \text{ V; } T_j = 25 \text{ °C} \qquad - \\ V_{GS} = 20 \text{ V; } V_{DS} = 0 \text{ V; } T_j = 25 \text{ °C} \qquad - \\ V_{GS} = 20 \text{ V; } V_{DS} = 0 \text{ V; } T_j = 25 \text{ °C} \qquad - \\ V_{GS} = 10 \text{ V; } I_D = 25 \text{ A; } T_j = 100 \text{ °C; } \qquad - \\ v_{GS} = 10 \text{ V; } I_D = 25 \text{ A; } T_j = 175 \text{ °C; } \qquad - \\ v_{GS} = 10 \text{ V; } I_D = 25 \text{ A; } T_j = 175 \text{ °C; } \qquad - \\ v_{GS} = 10 \text{ V; } I_D = 25 \text{ A; } T_j = 25 \text{ °C; } \qquad - \\ v_{GS} = 10 \text{ V; } I_D = 25 \text{ A; } T_j = 25 \text{ °C; } \qquad - \\ v_{GS} = 10 \text{ V; } I_D = 25 \text{ A; } T_j = 25 \text{ °C; } \qquad - \\ v_{GS} = 10 \text{ V; } I_D = 25 \text{ A; } T_j = 25 \text{ °C; } \qquad - \\ v_{GS} = 10 \text{ V; } I_D = 25 \text{ A; } I_D = 25 \text{ A; } I_D = 25 \text{ °C; } \qquad - \\ v_{GS} = 10 \text{ V; } I_D = 25 \text{ A; } I_D = 25 \text{ °C; } \qquad - \\ v_{GS} = 10 \text{ V; } I_D = 25 \text{ A; } I_D = 25 \text{ °C; } \qquad - \\ v_{GS} = 10 \text{ V; } I_D = 25 \text{ A; } I_D = 25 \text{ °C; } \qquad - \\ v_{GS} = 10 \text{ V; } I_D = 25 \text{ A; } I_D = 25 \text{ °C; } \qquad - \\ v_{GS} = 10 \text{ V; } I_D = 25 \text{ A; } I_D = 25 \text{ °C; } \qquad - \\ v_{GS} = 10 \text{ V; } I_D = 25 \text{ °C; } \qquad - \\ v$	- 10 10 4.32 6.21	500 100 100 5.1	μA nA nA
$\begin{array}{c} I_{GSS} & \text{gate leakage current} & V_{GS} = -20 \text{ V; } V_{DS} = 0 \text{ V; } T_j = 25 \text{ °C} & - \\ V_{GS} = 20 \text{ V; } V_{DS} = 0 \text{ V; } T_j = 25 \text{ °C} & - \\ \hline \\ R_{DSon} & \text{drain-source on-state} \\ \text{resistance} & V_{GS} = 10 \text{ V; } I_D = 25 \text{ A; } T_j = 100 \text{ °C;} & - \\ \text{see Figure 12; see Figure 13} & V_{GS} = 10 \text{ V; } I_D = 25 \text{ A; } T_j = 175 \text{ °C;} & - \\ \text{see Figure 12; see Figure 13} & V_{GS} = 10 \text{ V; } I_D = 25 \text{ A; } T_j = 25 \text{ °C;} & - \\ \text{see Figure 13} & V_{GS} = 10 \text{ V; } I_D = 25 \text{ A; } T_j = 25 \text{ °C;} & - \\ \text{see Figure 13} & - & - \\ \hline \\ R_G & \text{gate resistance} & f = 1 \text{ MHz} & - \\ \hline \\ Dynamic characteristics} & & - \\ \hline \\ Q_{G(tot)} & \text{total gate charge} & I_D = 0 \text{ A; } V_{DS} = 0 \text{ V; } V_{GS} = 10 \text{ V; } - \\ \hline \\ I_D = 25 \text{ A; } V_{DS} = 30 \text{ V; } V_{GS} = 10 \text{ V; } - \\ \hline \\ Q_{GS} & \text{gate-source charge} & - \\ \hline \\ Q_{GS(th-pl)} & \text{post-threshold gate-source charge} & - \\ \hline \\ Q_{GD} & \text{gate-drain charge} & - \\ \hline \end{array}$	10 4.32 6.21	100 100 5.1	nA nA
$V_{GS} = 20 \text{ V; } V_{DS} = 0 \text{ V; } T_j = 25 \text{ °C} \qquad - \\ P_{DSon} \qquad \text{drain-source on-state resistance} \qquad V_{GS} = 10 \text{ V; } I_D = 25 \text{ A; } T_j = 100 \text{ °C; see Figure 13} \\ \hline V_{GS} = 10 \text{ V; } I_D = 25 \text{ A; } T_j = 175 \text{ °C; see Figure 13} \\ \hline V_{GS} = 10 \text{ V; } I_D = 25 \text{ A; } T_j = 175 \text{ °C; see Figure 13} \\ \hline V_{GS} = 10 \text{ V; } I_D = 25 \text{ A; } T_j = 25 \text{ °C; see Figure 13} \\ \hline V_{GS} = 10 \text{ V; } I_D = 25 \text{ A; } T_j = 25 \text{ °C; see Figure 13} \\ \hline V_{GS} = 10 \text{ V; } I_D = 25 \text{ A; } T_j = 25 \text{ °C; see Figure 13} \\ \hline V_{GS} = 10 \text{ V; } I_D = 25 \text{ A; } V_D = 25 \text{ °C; see Figure 13} \\ \hline V_{GS} = 10 \text{ V; } I_D = 25 \text{ A; } V_D = 25 \text{ °C; see Figure 14} \\ \hline V_{GS} = 10 \text{ V; } I_D = 25 \text{ A; } V_D = 10 \text{ V; } I_D = 25 \text{ A; } I_D = 10 \text{ A; } V_D = 10 \text{ V; } I_D = 10 \text{ A; } V_D = 10 \text{ V; } I_D = 10 \text{ A; } V_D = 10 \text{ V; } I_D = 10 \text{ A; } V_D = 10 \text{ V; } I_D = 10 \text{ A; } V_D = 10 \text{ V; } I_D = 10 \text{ A; } V_D = 10 \text{ V; } I_D = 10 \text{ A; } V_D = 10 $	10 4.32 6.21	100 5.1	nA
$\begin{array}{c} R_{DSon} \\ R_{DSon} \\ \end{array} \begin{array}{c} drain\text{-source on-state} \\ resistance \\ \end{array} \begin{array}{c} V_{GS} = 10 \text{ V};  I_D = 25 \text{ A};  T_j = 100  ^{\circ}\text{C}; \\ \text{see } \overline{\text{Figure 12}}; \text{ see } \overline{\text{Figure 13}} \\ \hline V_{GS} = 10 \text{ V};  I_D = 25 \text{ A};  T_j = 175  ^{\circ}\text{C}; \\ \text{see } \overline{\text{Figure 12}}; \text{ see } \overline{\text{Figure 13}} \\ \hline V_{GS} = 10 \text{ V};  I_D = 25 \text{ A};  T_j = 25  ^{\circ}\text{C}; \\ \text{see } \overline{\text{Figure 13}} \\ \hline P_{GS} = 10 \text{ V};  I_D = 25 \text{ A};  T_j = 25  ^{\circ}\text{C}; \\ \text{see } \overline{\text{Figure 13}} \\ \hline P_{GS} = 10 \text{ V};  I_D = 25 \text{ A};  T_j = 25  ^{\circ}\text{C}; \\ \text{see } \overline{\text{Figure 13}} \\ \hline P_{GS} = 10 \text{ V};  I_D = 25 \text{ A};  T_j = 25  ^{\circ}\text{C}; \\ \text{see } \overline{\text{Figure 14}}; \\ \hline P_{GS} = 10 \text{ V};  I_D = 25 \text{ A};  T_j = 25  ^{\circ}\text{C}; \\ \hline P_{GS} = 10 \text{ V};  P_{GS} = 10 \text{ V}; \\ \hline P_{GS} = 10 \text{ V};  P_{GS} = 10 \text{ V}; \\ \hline P_{GS} = 10 \text{ V};  P_{GS} = 10 \text{ V}; \\ \hline P_{GS} = 25 \text{ A};  P_{DS} = 30 \text{ V};  P_{GS} = 10 \text{ V}; \\ \hline P_{GS} = 10 \text{ V};  P_{GS} = 10 \text{ V}; \\ \hline P_{GS} = 10 \text{ V};  P_{GS} = 10 \text{ V}; \\ \hline P_{GS} = 10 \text{ V};  P_{GS} = 10 \text{ V}; \\ \hline P_{GS} = 10 \text{ V};  P_{GS} = 10 \text{ V}; \\ \hline P_{GS} = 10 \text{ V};  P_{GS} = 10 \text{ V}; \\ \hline P_{GS} = 10 \text{ V};  P_{GS} = 10 \text{ V}; \\ \hline P_{GS} = 10 \text{ V};  P_{GS} = 10 \text{ V}; \\ \hline P_{GS} = 10 \text{ V};  P_{GS} = 10 \text{ V}; \\ \hline P_{GS} = 10 \text{ V};  P_{GS} = 10 \text{ V}; \\ \hline P_{GS} = 10 \text{ V};  P_{GS} = 10 \text{ V}; \\ \hline P_{GS} = 10 \text{ V};  P_{GS} = 10 \text{ V}; \\ \hline P_{GS} = 10 \text{ V};  P_{GS} = 10 \text{ V}; \\ \hline P_{GS$	4.32 6.21	5.1	
resistance	6.21		mΩ
$See \begin{tabular}{lllllllllllllllllllllllllllllllllll$		7.3	
$R_{G} \qquad \text{gate resistance} \qquad f = 1 \text{ MHz} \qquad - \\ \hline \textbf{Dynamic characteristics} \\ Q_{G(tot)} \qquad \text{total gate charge} \qquad \boxed{I_{D} = 0 \text{ A; V}_{DS} = 0 \text{ V; V}_{GS} = 10 \text{ V}} \qquad - \\ \hline I_{D} = 25 \text{ A; V}_{DS} = 30 \text{ V; V}_{GS} = 10 \text{ V;}} \qquad - \\ \hline Q_{GS} \qquad \text{gate-source charge} \qquad \qquad \text{see Figure 14; see Figure 15}} \qquad - \\ \hline Q_{GS(th-pl)} \qquad \text{post-threshold gate-source charge} \qquad \qquad - \\ \hline Q_{GD} \qquad \text{gate-drain charge} \qquad \qquad - \\ \hline \\ \hline \end{tabular}$			mΩ
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	2.7	3.2	mΩ
$\begin{array}{c} Q_{G(tot)} & \text{total gate charge} & I_D = 0 \text{ A; } V_{DS} = 0 \text{ V; } V_{GS} = 10 \text{ V} \\ I_D = 25 \text{ A; } V_{DS} = 30 \text{ V; } V_{GS} = 10 \text{ V; } \\ Q_{GS} & \text{gate-source charge} & \text{see } \underline{\text{Figure 14; see } \underline{\text{Figure 15}}} & \text{-} \\ Q_{GS(th\text{-pl})} & \text{post-threshold gate-source charge} & \text{-} \\ Q_{GD} & \text{gate-drain charge} & \text{-} \\ \end{array}$	1.1	-	Ω
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$			
QGS     gate-source charge       QGS(th-pl)     post-threshold gate-source charge       QGD     gate-drain charge   - Indeed, see Figure 15 - Indeed, see Figure 1	110	-	nC
Q <sub>GS(th-pl)</sub> post-threshold gate-source charge - charge  Q <sub>GD</sub> gate-drain charge	130	-	nC
charge  Q <sub>GD</sub> gate-drain charge -	43	-	nC
	21	-	nC
	28	-	nC
$V_{GS(pl)}$ gate-source plateau voltage $I_D = 25 \text{ A}$ ; $V_{DS} = 30 \text{ V}$ ; see Figure 14; see Figure 15	5.2	-	V
$C_{iss}$ input capacitance $V_{DS} = 30 \text{ V; } V_{GS} = 0 \text{ V; } f = 1 \text{ MHz;}$ - $T_j = 25 \text{ °C; see } \frac{Figure \ 9}{Figure \ 9}$	8079	-	pF
$C_{oss}$ output capacitance $V_{DS}$ = 30 V; $V_{GS}$ = 0 V; f = 1 MHz; - $T_j$ = 25 °C; see Figure 16	971	-	pF
$C_{rss}$ reverse transfer capacitance $V_{DS} = 30 \text{ V}; V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}; - T_j = 25 ^{\circ}\text{C}; see Figure 16; see Figure 9}$	492	-	pF
$t_{d(on)}$ turn-on delay time $V_{DS} = 30 \text{ V}; R_L = 0.5 \Omega; V_{GS} = 10 \text{ V};$ -	31	-	ns
$t_r$ rise time $R_{G(ext)} = 1.5 \Omega$		-	ns
t <sub>d(off)</sub> turn-off delay time -	26	-	ns
t <sub>f</sub> fall time -	26 77		

Table 7. Characteristics ... continued

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Source-drai	n diode					
V <sub>SD</sub>	source-drain voltage	$I_S = 25 \text{ A}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C};$ see <u>Figure 17</u>	-	0.88	1.2	V
t <sub>rr</sub>	reverse recovery time	$I_S = 25 \text{ A}$ ; $dI_S/dt = -100 \text{ A/}\mu\text{s}$ ;	-	54	-	ns
Qr	recovered charge	$V_{GS} = 0 \text{ V}; V_{DS} = 30 \text{ V}$	-	97	-	nC

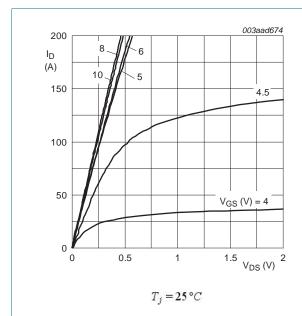


Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values

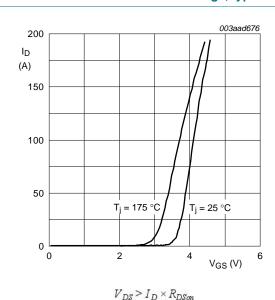
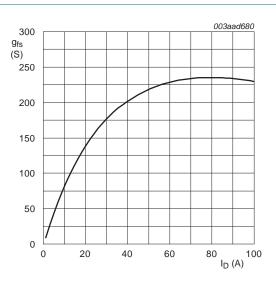
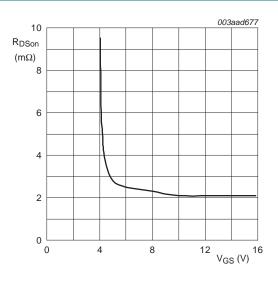


Fig 7. Transfer characteristics: drain current as a function of gate-source voltage; typical values



 $T_j = 25$  °C;  $V_{DS} = 30$ V

Fig 6. Forward transconductance as a function of drain current; typical values



 $T_j = 25$  °C;  $I_D = 25$  A

Fig 8. Drain-source on-state resistance as a function of gate-source voltage; typical values

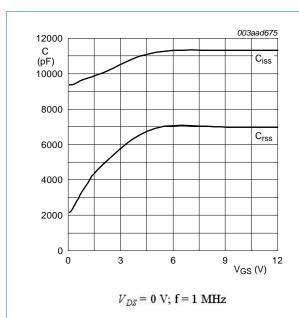
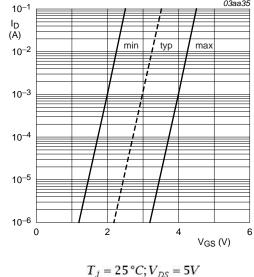


Fig 9. Input and reverse transfer capacitances as a function of gate-source voltage, typical values



 $T_j = 25 \, ^{\circ}C; V_{DS} = 5V$ 

Fig 10. Sub-threshold drain current as a function of gate-source voltage

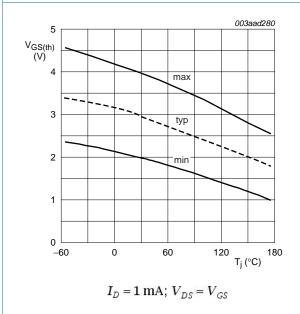


Fig 11. Gate-source threshold voltage as a function of junction temperature

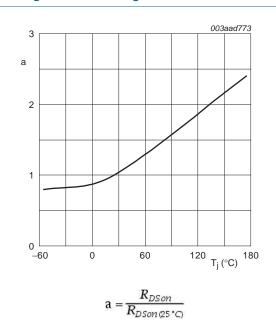
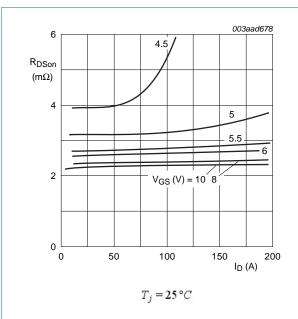


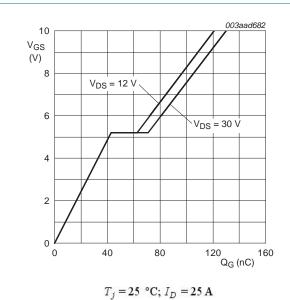
Fig 12. Normalized drain-source on-state resistance factor as a function of junction temperature



V<sub>GS</sub>(pl)
V<sub>GS</sub>(th)
V<sub>GS</sub>
Q<sub>GS1</sub> Q<sub>GS2</sub>
Q<sub>GG</sub>(tot)
003aaa508

Fig 13. Drain-source on-state resistance as a function of drain current; typical values

Fig 14. Gate charge waveform definitions



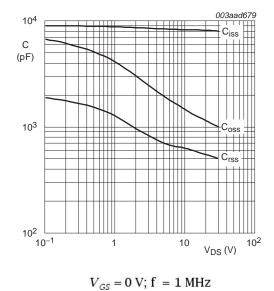
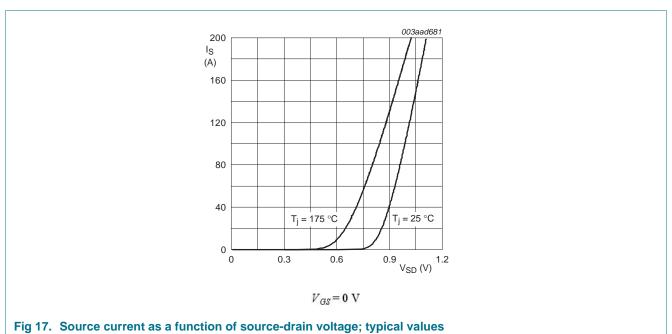


Fig 15. Gate-source voltage as a function of gate charge; typical values





## 8. Package outline

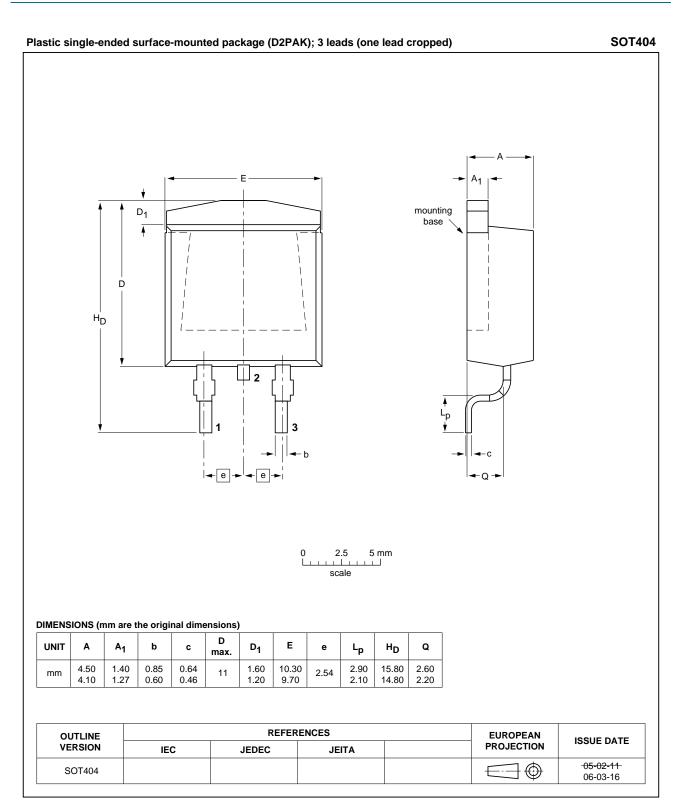


Fig 18. Package outline SOT404 (D2PAK)

## 9. Revision history

#### Table 8. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
PSMN3R0-60BS v.1	20120322	Product data sheet	-	-

## 10. Legal information

#### 10.1 Data sheet status

Document status[1] [2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions'
- [3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URLhttp://www.nxp.com.

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PSMN3R0-60BS

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## PSMN3R0-60BS

#### N-channel 60 V 3.2 mΩ standard level MOSFET in D2PAK

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